

# A Simple Digital Method for Compensation of Baseline Drift in Low-Frequency Small-Signal Waveform Measurements

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#### **Abstract**

The need to measure relatively small signals mixed with drifting background levels and random noise is a common requirement in the laboratory environment. This report presents a simple device that continuously compensates for drifting baseline levels in systems where the background can be measured independently. The resulting level of automation allows the effects of random noise to be diminished through extensive signal averaging. For added flexibility, parameters such as the input voltage range and background sampling rate can be set by the user. All required hardware and software are provided and explained in detail.

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#### 1. Introduction

In many electronic measurements, low-level broadband signals must be extracted, which are superimposed on a slowly varying background that drifts over a range many times that of the signal amplitude. The problem is compounded when the background contains higher frequency components (i.e., noise). In this report, a technique is presented that was devised at the U. S. Army Research Laboratory (ARL) to mitigate the effects of long-term baseline drift and thus allow the application of additional techniques for noise removal, such as signal averaging.

This technique is a by-product of ARL's investigations of methods for the remote detection and identification of airborne gases in the battlefield environment. One proposed method, called infrared fluorescence (IRF), uses a high-power laser to selectively excite one of an aerosol's constituent gaseous species. A telescope is then used to collect and analyze the characteristic infrared radiation emitted during that component's subsequent de-excitation processes. It is the detection of these fluorescent emissions that motivated the present work. They are not only intrinsically weak, but also superimposed on a noisy, drifting background. In the current discussion, drift and noise are distinguished by their respective nonrandom and random natures. In the IRF apparatus, drift arises from a combination of variations in the inherent thermal background radiation that permeates a room temperature environment; of changes in the properties of electronic components such as batteries, detectors, and amplifiers; and of stray electric or magnetic fields. These sources tend to be nonrepetitive and do not average out to zero over time. On the other hand, all detection systems and amplifiers are subject to a variety of random noises, such as Johnson noise, shot noise, and 1/f noise (Moore 1983). Clearly, the ability to extract the desired IR emission from the profusion of background and noise signals is both an essential requirement and a challenging task.

The ability to recover useful information from a detected signal (i.e., a mixture of a pure signal and random noise) is not a function of the absolute value of the pure signal but rather the signal-to-noise (SNR) ratio.

 $SNR = S/N \tag{1}$ 

S is the amplitude of the pure signal and N is the amplitude of the random noise. The larger the SNR, the smaller the minimum detectable pure signal that can be recovered. Random noise has an equal probability of having a positive or negative sense and therefore averages out to zero over a long period of time. For a repetitive pure signal, the SNR can be increased by averaging the detected signal over multiple cycles. The improvement in the SNR with signal averaging can be expressed as:

$$SNR_{ave} = \sqrt{n} \cdot SNR_0. \tag{2}$$

SNR<sub>ave</sub> is the signal-to-noise ratio of multiple averaged signals, SNR<sub>0</sub> is the signal-to-noise ratio of a single detector signal measurement, and n is the number of repetitive signals that are averaged. Another signal recovery technique, lock-in amplification, may be superior to signal averaging for improving SNR when the waveform is well-defined. However, the availability of computer-assisted data acquisition systems has, in recent years, made simple signal averaging an attractive alternative to other hardware intensive methods.

As already mentioned, background drift, unlike random noise, does not have an equal probability of having a positive or negative sense. Therefore, background drift does not have to average out to zero, even over a very long period of time. As a result, signal averaging will not eliminate a drifting background from a repetitive signal. Often during signal averaging, drift deviations may accumulate to the point where they swamp the averaged signal. A differential detection technique can be utilized to eliminate the background in systems where the background can be measured separately. Figure 1 illustrates a schematic of this process. The Signal + Background and Background signals are supplied to the two inputs of a differential amplifier. The output from a differential amplifier is proportional to the difference between the two inputs. Thus, the output from the differential amplifier will be the desired pure signal with the background element removed.

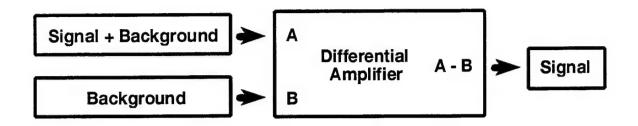


Figure 1. Schematic of the Differential Detection Process.

Clearly, the effort to recover a desired low-level signal immersed in a noisy drifting background, such as the present IR emission signal, can benefit from the application of both signal averaging and differential detection techniques—provided that the background signal can be independently measured. In the IRF scenario, the signal is the result of and temporally correlated with the pulsing of the high-power excitation laser. When the laser is off, the background signal can be measured; when the laser is on, the combined background and IR emission signal can be recorded.

With a known background signal, an external variable voltage source can be configured to mimic the measured background level. This external signal can be supplied to the background input of the differential amplifier to allow the pure IR emission signal to be separated from the background signal. An illustration of a manual method for performing this operation is presented in Figure 2. The operator, hereafter called Differential Person, observes the independently measured background signal level and adjusts the available potentiometer to a level that reproduces the current background level. This manually generated background reference signal is then subtracted from the combined IR emission and background signal via the differential amplifier.

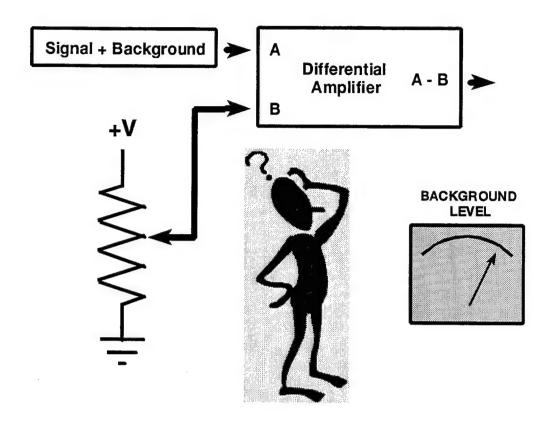


Figure 2. Manual Method for Generating External Background Signals.

Obviously, this manual method for generating the external background reference signal has a number of drawbacks. Background levels with even a moderate amount of drift may tax Differential Person's ability to manually recreate the background signal. Small signal measurements require sensitive measurement scales that span only a small fraction of the total signal's amplitudes. Under these conditions, even a minor deviation between the measured background level and the externally generated background reference signal may be sufficient to drive the differential amplifier's output signal beyond the available signal measurement range. Also, the desire to obtain a large number of repetitive measurements, so that the SNR can be reduced through averaging, may once again stress the operator's ability to consistently recreate the measured background signal level.

This report presents an automated baseline adjustment device (BAD) that can assist with the recovery of small signals that are mixed with a drifting background signal and random noise. The BAD monitors the output from the differential amplifier during periods when only the background signal is being detected. It then adjusts the potential applied to the background-only input of the differential amplifier to drive its output to a desirable baseline level. First, an overview will be presented of the hardware that performs this background subtraction process. The required electronic circuitry and its operation will then be considered in increasing detail. Included in these electronics is a controller that orchestrates the activities of the various components. The software that drives this controller will also be provided and discussed. While the apparatus described was designed for a specific application, its general operating principles, as well as many of its physical details, can be readily adapted to many signal recovery tasks.

### 2. Baseline Adjustment Device Embodiment

2.1 Overview. A schematic overview of the BAD hardware is illustrated in Figure 3. The ease with which this device can be implemented is due, in part, to the small number of external connections that need to be provided. A timing signal must be supplied to notify the BAD that the measurement system is currently recording only a background signal. It is during these intervals that adjustments to the baseline level are appropriate. For the IR emission measurement system this signal is synchronized with the pulsing of the high-power excitation laser. Specifically, baseline adjustments are performed while the laser is off and the detection system is recording only the ambient background level.

During the intervals that the laser is off, the BAD samples a feedback signal from the measurement system that indicates the amplitude of the present background level. In the case of the IR measurement system, this feedback is provided by the output of the differential amplifier. The actual background signal and the BAD-generated reproduction of the background level from the most recent sampling are fed into the differential amplifier's two inputs. Assuming that the background drift is not inordinately high, the differential amplifier's output can be expected to be

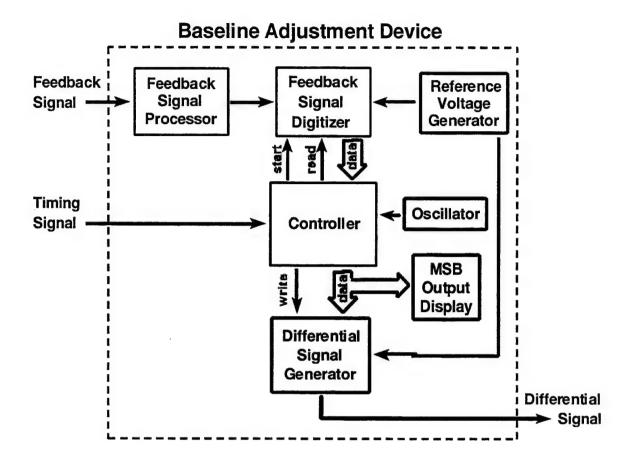


Figure 3. Schematic Overview of Baseline Adjustment Device Hardware.

near zero. This is in fact the very condition that allows small signals to be recorded on very sensitive scales. Depending on the sense in which the feedback signal deviates from the desired value, the BAD will either increase or decrease the magnitude of its output signal. This output signal provides the differential signal voltage that is looped back to the background-only input of the differential amplifier. Variations in this signal therefore alter the output from the differential amplifier. This closed-loop method has the effect of providing a signal to the background reference input of the differential amplifier that closely mimics the current background level. The BAD then resamples the feedback signal and adjusts the magnitude of the externally generated reference signal in an iterative fashion until the desired feedback signal level is obtained.

A brief overview of the electrical subsystems that make up the BAD is now provided. Input feedback signals are first scaled by a feedback signal processor. The function of this processor is to adjust the magnitude of the feedback signals to match the allowable input range of the subsequent feedback signal digitizer. This feedback signal processing is performed by an operational amplifier (op amp). The actual details of the characteristics of this op amp will depend on the constraints of the specific measurement problem. After being properly scaled, the feedback signal is digitized by an analog-to-digital convertor (ADC). This conversion from an analog to a digital signal is necessary to allow the inherently digital controller to read the current feedback signal value. The controller compares this current feedback signal level to the desired level and adjusts the value of a digital word that is output to the differential signal generator. The differential signal generator is a digital-to-analog convertor (DAC) that outputs an analog voltage that corresponds to the value of its digital input. Thus, the controller can adjust the magnitude of the analog differential signal by varying the value of the digital word that it writes to the differential signal generator.

The ADC and the DAC measure and produce analog voltages by comparing them to a reference voltage of known value. A reference voltage generator provides a constant, well-defined voltage that guarantees the accuracy of the convertor's performance. The controller's actions are paced by a crystal oscillator. Finally, the range of digital values that the controller can output to the differential signal generator is limited by the number of bits available for output. For this reason, it is desirable to operate the differential signal generator near the middle of its operating range. The most significant bits (MSB) of the digital word that the controller outputs to the differential signal generator are monitored by an MSB output display so that this condition can be maintained.

The problem described previously is also solvable by a number of analog circuits, which employ a looping process that is analogous to the method described previously. However, the utilization of digital elements of the type described in this report offer the advantages of enhanced precision, flexibility, and noise immunity. Moreover, the key components of this system are inexpensive, reliable, and widely available.

2.2 Electronic Details. The electronic circuitry and its operation are now presented in detail. A schematic diagram of this circuitry is illustrated in Figure 4. The two required inputs to the BAD are shown in the upper left-hand corner of this figure. For the IR emission measurements, the feedback signal is provided by the output from the differential amplifier, which is amplified and buffered through the vertical signal out port of a digital processing oscilloscope. This buffered output has a maximum range of ±2 volts. As configured, the ADC0805 ADC that is used to digitize the feedback signal can convert analog signals over the range from 0 to 5 volts (National Semiconductor Company 1993). The feedback signal is matched to the measurement range of the ADC by the feedback signal processing circuitry consisting of the op amp IC1-A and the resistance dividing network of R8 and R9. The LM324 op amp is configured as a noninverting amplifier with a gain of 2.5. Thus, this op amp converts the ±2-volt feedback signal to a ±5-volt signal. This amplified signal is divided by the resistance network of R8 and R9 that is referenced to the +5-volt potential of V5REF. The function of this resistor network is to convert the bipolar ±5-volt output from the op amp to a 0-5-volt signal that matches the measurement range of the ADC.

The external timing signal is routed to the RA3 input line of the PIC16C55 controller. When the controller determines that the timing signal indicates that background adjustment is appropriate, the controller initiates an ADC by sending a negative pulse from its RA2 output to the WR bar input of the ADC0805. After waiting a period of time that exceeds the ADC's conversion time, the controller instructs the ADC to output the new conversion value on its DB# output lines by pulling its RD bar input low via output line RA1. The controller then reads in this value through its RB# inputs. The 8-bit size of this digital word and the 5-volt measurement range of the ADC offer conversion resolutions of approximately 19 mV.

The PIC16C55 controller compares the new ADC conversion value to a preprogrammed target value and determines the sense of the deviation. Depending on whether the conversion value is too high or too low, the controller will decrease or increase the value of the digital word

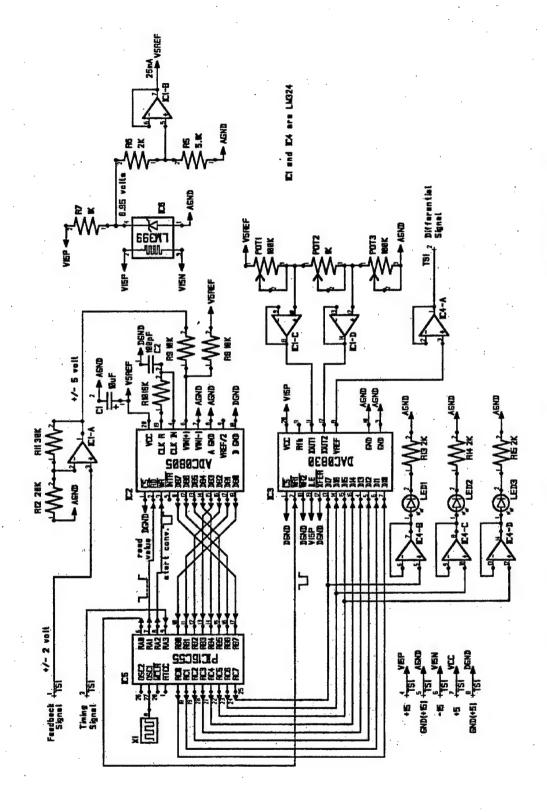


Figure 4. Schematic Diagram of Baseline Adjustment Device Electronics.

that it writes to the DI# inputs of the DAC0830 DAC via its RC# output lines. The controller forces the DAC to read in this new value by sending a low pulse from its RA0 output to the DAC's WR1 bar input.

The DAC0830 DAC uses an internal network of resistors to generate an output voltage that has a value between the potential supplied to input IOUT2 and the potential supplied at IOUT1. Specifically, the output voltage at VREF will be:

$$V_{VREF} = V_{IOUT2} + (D/256) \times (V_{IOUT1} - V_{IOUT2}).$$
 (3)

 $V_{VREF}$  is the DAC output voltage at VREF,  $V_{IOUT2}$  is the potential supplied to input IOUT2,  $V_{IOUT1}$  is the potential supplied to input IOUT1, and D is the value of the digital word  $(0 \le D \le 255)$  supplied to the input's DI#. This ability to determine the range and span of DAC output values allows the required precision of the differential signal to be achieved. In combination, the potentiometers POT1 and POT3 determine the range of analog voltages that the DAC can produce. The magnitude of the setting of POT2, relative to the settings of POT1 and POT3, determines the span of the DAC's output range. By setting POT2 arbitrarily small, the output precision of the DAC can be made arbitrarily high over a very small range of voltages. Op amps IC1-C and IC1-D are used to buffer the input voltages from the potentiometer network to the DAC IOUT1 and IOUT2 inputs, while op amp IC4-A buffers the DAC's output voltage.

The BAD's ability to compensate for drifting background levels is maximized when the DAC is supplying a voltage that is near the middle of its range of output voltages. This condition is monitored by noting the value of the MSBs. The data lines of the DAC's three MSBs are buffered by op amps IC4-B, IC4-C, and IC4-D, and the corresponding data is displayed by LED1, LED2, and LED3. When operating, the potentiometer network is adjusted so that either LED1 is on while LED2 and LED3 are off or LED1 is off while LED2 and LED3 are on. Either of these conditions denote that the DAC is operating near the middle of its allowed range of output voltages.

A number of supply voltages must be provided to this electronic circuitry. For instrumentation that incorporates both analog and digital components, it is generally desirable to isolate the corresponding power supplies. This practice shields the analog components from the spikes that are commonly found on digital power lines. The digital power requirements are fulfilled by the 5-volt potential supplied across VCC and DGND. Analog power is provided via the +15-volt potential between V15P and AGND, and the -15-volt potential across V15N and AGND. These ±15-volt potentials are supplied directly to the op amps and the DAC. A +5-volt potential is also derived from the ±15-volt supply by an LM399 precision reference (National Semiconductor Company 1988). This monolithic device incorporates an active zener that is temperature stabilized by a heater to provide a stable, low-power reference voltage. An op amp scales this reference voltage to the required 5-volt potential and increases the available drive current to greater than 25 mA. This precision 5-volt potential between V5REF and AGND powers the potentiometer network and the analog portion of the ADC.

### 3. Baseline Adjustment Device Software

The internal processes of the BAD are orchestrated by a PIC16C55 controller. Specifically, the controller synchronizes the BAD's operation with the background-only phase of the measurement system, initiates the ADCs of the feedback signal, and adjusts the magnitude of the differential signal in an appropriate manner. The controller performs these operations by repeatedly executing the instructions contained in its erasable read-only memory (EPROM). A flowchart of this software is presented in Figure 5. For clarity, the macros that perform described functions are enclosed in square brackets in this figure. A listing of this code is presented in the Appendix.

When the PIC16C55 controller is powered up, a number of initializing procedures are executed. Upon power up, the input/output (I/O) pins default to a high-impedence input state. The macro SetTRIS defines the appropriate status of the I/O pins as either input or output. Even though the real-time clock/counter (RTCC) and watch-dog timer (WDT) capabilities of the PIC16C55 are not utilized in this application, the SetOPTION macro is used to define the associated option

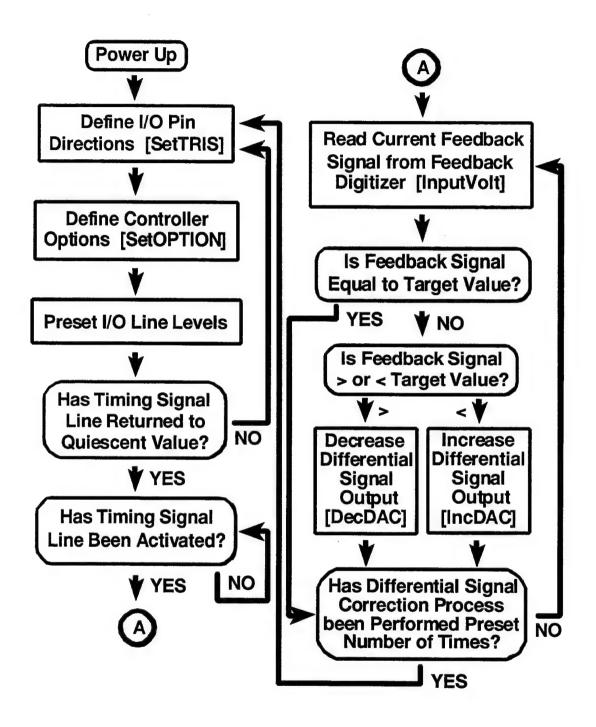


Figure 5. Flowchart of PIC16C55 Controller Software.

register to convenient, benign values. The I/O pins that were defined to be outputs are then set to an initial state that is compatible with the connected components. These initializing procedures are actually executed on a regular basis to avoid potential problems resulting from the corruption of register contents, which can occur in electrically noisy environments (Microchip Technology Inc. 1992).

Once the initiation process is completed, the controller monitors the timing signal input line to determine when baseline adjustment is appropriate. After the measurement system has entered a background-only phase, the controller initiates an ADC and reads in the current value of the feedback signal. If this feedback signal matches the preprogrammed target value, then background adjustment is not required. If the feedback signal is found to deviate from the target value, the controller then determines the sense of the deviation and increases or decreases the magnitude of the differential signal as appropriate. This differential signal adjustment process is repeated a preset number of times that depend on the time interval available and the estimated maximum background drift. The initialization routine is then reentered, and the entire process is repeated as a free running loop.

### 4. A Performance Example

Figure 6 illustrates an example of the BAD's performance. The upper oscilloscope trace displays a collection of repetitive, narrow rectangular pulses superimposed on a relatively low-frequency ramped-sawtooth waveform. For the purposes of this example, the narrow pulses represent the desired signal that is to be recovered and the broad sawtooth mimics a drifting background that is to be eliminated. The middle trace shows the independent measurement of this background signal as it is fed into the feedback signal input of the BAD. An appropriate timing signal is supplied to the BAD's timing input that triggers the BAD to update the magnitude of its differential output signal every 20 mS. This differential signal is routed to one input of a differential amplifier while the signal shown in the upper trace is routed to the other input. The output from the differential amplifier, which is the difference between its two inputs, is shown by the bottom trace. The low-frequency sawtooth background signal is effectively

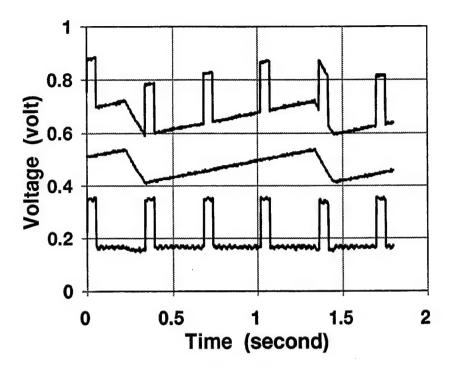


Figure 6. Example of Baseline Adjustment Device Performance.

eliminated. Signal averaging techniques could now be applied to this recovered signal to eliminate the presence of random noise.

### 5. Conclusions

An automated baseline adjustment device has been presented that can simplify the measurement of small signals that are combined with a drifting background signal and random noise. Although developed to assist with the measurement of IR emissions from gaseous media, this system can be applied generally to systems that offer an independent measurement of the background level. The required hardware has been presented in increasing complexity beginning with an overview of the instrument's functions and progressing through a complete description of the electronic circuitry and its logic. Similarly, the software that drives the embedded controller is presented as a flowchart, explained in detail, and listed in the Appendix.

### 6. References

Microchip Technology Inc. Microchip Data Book. Second edition, Chandler, AZ, 1992.

Moore, J. H., C. C. Davis, and M. A. Coplan. *Building Scientific Apparatus*. Reading, MA: Addison-Wesley Publishing Co., Inc., 1983.

National Semiconductor Company. Linear Databook 2. Santa Clara, CA, 1988 edition.

National Semiconductor Company. Data Acquisition Databook. Santa Clara, CA, 1993 edition.

## Appendix:

PIC16C55 Controller Software Listing

```
; IR FLUORESCENCE BASELINE ADJUSTMENT DRIVER
; PROGRAM FOR PIC16C55 MICROCONTROLLER
; VERSION 3.0 JULY 1997
; WRITTEN FOR ASSEMBLY BY MICROCHIP TECHNOLOGY MPALC
: MACRO ASSEMBLER.
; IF YOU HAVE ANY QUESTIONS ABOUT THIS SOFTWARE CONTACT:
    Dr. Thomas W. Kottke
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    Aberdeen Proving Ground, MD 21005
    tel: (410) 278-2557
    fax: (410) 278-9969
    e-mail: kottke@arl.army.mil
----- CONSTANT DEFINITIONS -----
                                      ;direct action result
                     00x0
          EQU
                                      ; to W
                                      ;direct action result
                     0x01
F
          EOU
                                      ; to F##
                                      ;target differential
                     b'01100000'
          EQU
Target
                                      ; op amp output
                                      ; # correction steps
                     b'00011000'
NumCor
          EOU
               ----- BIT DEFINITIONS ------
                     0 \times 00
                                      ; carr flag of
          EQU
CarryBit
                      ; Status regist
                                      ; zero flag of Status
ZeroBit
          EQU
                      0x02
                                       ; register
                                      ;bit 0 of HandShake
                     0x00
DACWrite
          EQU
                                      ;bit 1 of HandShake
                     0x01
          EOU
ADCRead
                                      ;bit 2 of HandShake
ADCWrite
          EQU
                      0x02
                                      ;bit 3 of HandShake
          EQU
                      0x03
Trigger
;----- REGISTER DEFINITIONS -----
                     0x03
                                      ; status register, R3
         EQU
Status
                                       ; handshaking reg, R5
                      0x05
HandShake EQU
                                      ;ADC input reg,
                                                       R6
                      0x06
          EQU
ADCInput
                                      ;DAC output reg,
                                                       R7
                     0x07
DACOutput EQU
                                      ;interval delay
                     80x0
Looper
          EQU
                                                       R8
                                      ; counter req,
                                      ; ADC value reg,
                                                       R9
                      0x09
ADCValue
          EQU
                                      ;DAC value reg,
                                                       R10
                      A0x0
DACValue EQU
```

```
LoopCor
          EQU
                     0x0B
                                      ; correction
                                      ; counter reg.
                                                      R11
PrevVal
          EQU
                     0x0C
                                      ;previous value
                                                      R12
defines I/O pin directions
;SetOPTION set prescalar options
;Standby place 16C55 in standby mode
;InputVolt reads in voltage via ADC
;OutputVoltsources voltage via DAC
SetTRIS
         MACRO
                                      ; MACRO to set I/O
          ; directions
                                      ;0=output 1=input
          MOVLW
                     b'1000'
                                      ; define HandShake
                                      ; template
          TRIS
                     HandShake
                                      ; load R5 TRIS reg
          MOVLW
                     b'11111111'
                                      ; def ADCInput
                                      ; template
          TRIS
                     ADCInput
                                      ;load R6 TRIS reg
          MOVLW
                     b'00000000'
                                      ; def DACOutput
                                      ; template
          TRIS
                     DACOutput
                                      ;load R7 TRIS reg
          ENDM
                                      ; end of MACRO
SetOPTION
         MACRO
                                      ; MACRO to set
                                      ; prescalar options
                     b'00111111'
          MOVLW
                                      ; def OPTION template
          OPTION
                                      ; load OPTION register
          ENDM
                                      ; end of MACRO
Standby
          MACRO
                                      ; MACRO to place 16C55
                                      ; in standby mode
          SetTRIS
                                      ;set I/O directions
          SetOPTION
                                      ;set prescalar
                     ; options
          BSF
                     HandShake, DACWrite; set DACWrite high
          BSF
                     HandShake, ADCRead ; set ADCRead high
```

```
BSF
                        HandShake, ADCWrite; set ADCWrite
                        ; high
                                           ; clear watch dog
           CLRWDT
           ; timer
                                           end of MACRO
           ENDM
InputVolt
                                           ;MACRO to read in a
           MACRO
                                           :voltage from ADC
                        InputVolt1
                                           ; define location
           LOCAL
                                           ;define location
           LOCAL
                        InputVolt2
           BCF
                        HandShake, ADCWrite; pull ADCWrite low
                                           ;load W with value
                        b'00010000'
           MOVLW
                                           ;transfer W to Looper
           MOVWF
                        Looper
                                           ;decr Looper, =0 ?
InputVolt1 DECFSZ
                        Looper, F
                                           ;(no) go to In..Volt1
                        InputVolt1
           GOTO
           BSF
                        HandShake, ADCWrite; (yes) pull ADCWrite
                                           ; high
                        b'11111111'
                                           ;load W with value
           MOVLW
                                           ;transfer W to Looper
                        Looper
           MOVWF
                                           ;decr Looper, =0 ?
InputVolt2 DECFSZ
                        Looper, F
                                           ;(no) go to In.. Volt2
                        InputVolt2
           GOTO
                        HandShake, ADCRead ; (yes) pull ADCRead
           BCF
                                           ; low
                                           ;settling delay
           NOP
           NOP
           NOP
           MOVF
                        ADCInput, W
                                          ; move ADCInput to W
                        ADCValue
                                           ; move W to ADCValue
           MOVWF
                        HandShake, ADCRead ; pull ADCRead high
           BSF
                                           ; end of MACRO
           ENDM
, ______
                                           ; MACRO to source a
OutputVolt MACRO
                                           ; voltage through DAC
                                           ;define location
           LOCAL
                        OutVolt1
           MOVF
                        DACValue, W
                                           ; move DACValue to W
                                           ; move W to DACOutput
           MOVWF
                        DACOutput
                        HandShake, DACWrite; pull DACWrite low
           BCF
                                          ;load W with value
                        b'00010000'
           MOVLW
                                          ; move W to Looper
                        Looper
           MOVWF
                                          ;decr Looper, =0 ?
                        Looper, F
OutVolt1
           DECFSZ
                                           ;(no) go to OutVolt1
           GOTO
                        OutVolt1
                        HandShake, DACWrite; pull DACWrite high
           BSF
```

;				
; ******************** SOURCE CODE ****************				
NotReady	Standby		; MACRO	
-	BTFSC	HandShake, Trigger	trigger line clear?	
	GOTO	NotReady	;(no) go to NotReady	
Ready	BTFSS	_	r; (yes) trig line set?	
-	GOTO	Ready	;(no) go to Ready	
	MOVLW	NumCor	;(yes) load W	
	MOVWF	LoopCor	;move W to Looper	
Correct	InputVolt	_ 0 0 1 0 0 0	; MACRO	
	MOVLW	Target	;load W with Target	
			; value	
	SUBWF	ADCValue,W	;sub W from ADCValue	
	BTFSC	Status, ZeroBit	;result=0 ?	
	GOTO	Check	; (yes) go to Check	
			•	
	BTFSS	Status,CarryBit	;(no) result<0 ?	
	GOTO	IncDAC	;(yes) go to IncDAC	
	GOTO	DecDAC	;(no) go to DecDAC	
IncDAC	MOVF	DACValue, W	;move DACValue to W	
	MOVWF	PrevVal	;move W to PrevValue	
	INCF	DACValue, F	;increment DACValue	
	BTFSC	Status,ZeroBit	;DACValue=0 ?	
	GOTO	DACOver	;(yes) go to DACOver	
	GOTO	DACNoOver	;(no) go to DACNoOver	
DACOver	MOVLW	b'11111111'	;load W with 255	
77.017.0	MOVWF	DACValue	; move W to DACValue	
DACNoOver	OutputVolt		; MACRO	
	GOTO	Check	;jump	
DecDAC	MOVF	DACValue,W	;move DACValue to W	
	MOVWF	PrevVal	;move W to PrevValue	
	DECF	DACValue, F	;decrement DACValue	
	MOVLW	b'11111111'	;load W with 255	
	SUBWF	DACValue,W	; sub W from DACValue	
	BTFSC	Status, ZeroBit	;DACValue=255 ?	
	GOTO	DACUnder	; (yes) go to DACUnder	
	GOTO	DACNoUnder	; (no) goto DACNoUnder	
DACUnder	CLRF	DACValue	;set DACValue=0	
DACNoUnder	OutputVolt		; MACRO	
Check	DECFSZ	LoopCor	;Dec LoopCor, =0 ???	

GOTO	Correct	;(no) go to Correct
MOVF	PrevVal,W	<pre>;(yes) move PrevVal ; to W</pre>
SUBWF	DACValue,W	subt W from DACVal
BTFSS	Status, CarryBit	;is carry bit set ??
GOTO	NotReady	;(no) go to NotReady
MOVF	<pre>PrevVal,W ; to W</pre>	;(yes) move PrevVal
MOVWF	DACValue	; move W to DACValue
OutputVolt		; MACRO
GOTO	NotReady	;go to NotReady
END		;end of code

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The need to measure relatively small signals mixed with drifting background levels and random noise is a common requirement in the laboratory environment. This report presents a simple device that continuously compensates for drifting baseline levels in systems where the background can be measured independently. The resulting level of automation allows the effects of random noise to be diminished through extensive signal averaging. For added flexibility, parameters such as the input voltage range and background sampling rate can be set by the user. All required hardware and software are provided and explained in detail.					
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